

APT User Meeting

Tuesday 19 November 2024

Advancement in Instrumentation - Room 203 (large seminar room) (13:00 - 14:40)

time	[id] title	presenter
13:00	[25] Advancements in 3D Field Ion Microscopy for Atomic-Scale Material Characterization	KLAES, Benjamin
13:40	[10] Project SATMET: Combining Atom Probe Tomography and Transmission Electron Microscopy in a single tool	ZAKIROV, Aidar
14:00	[31] Technology and Applications of the LEAP 6000XR and Invizo 6000 atom probes	CHEMNITZER, Rene
14:20	[36] AdAPTS: An Adaptive Atom Probe Tomography Simulation Library	LÜKEN, Julian